

Notice of References Cited	Application/Control No. 10/716,748		Applicant(s)/Patent Under Reexamination POLCAWICH ET AL.	
	Examiner Sang Nguyen		Art Unit 2877	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,608,683	08-2003	Pilgrim et al.	356/432
*	C	US-6,600,558	07-2003	Ueno et al.	356/246
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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